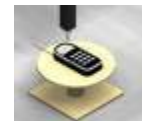




PCTEST ENGINEERING LABORATORY, INC.

6660-B Dobbin Road, Columbia, MD 21045 USA
Tel. 410.290.6652 / Fax 410.290.6554
http://www.pctestlab.com



HEARING AID COMPATIBILITY

Applicant Name:
Samsung Electronics, Co. Ltd.
18600 Broadwick St.
Rancho Dominguez, CA 90220
United States

Date of Testing:
July 14-15, 2010
Test Site/Location:
PCTEST Lab, Columbia, MD, USA
Test Report Serial No.:
OY1007131167.A3L

FCC ID: A3LSGHT249

APPLICANT: SAMSUNG ELECTRONICS, CO. LTD.

Application Type: Certification
FCC Rule Part(s): § 20.19(b)
HAC Standard: ANSI C63.19-2007 §6.3(v), §7.3(v)
FCC Classification: Licensed Transmitter Held to Ear (PCE)
EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth
Model(s): SGH-T249
Tx Frequency: 824.20 - 848.80 MHz (GSM 850)
1850.20 - 1909.80 MHz (GSM 1900)
Test Device Serial No.: Pre-Production Sample [S/N: FH-152-C]

C63.19-2007 HAC Category: M3 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2007 and had been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested for North American bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

PCTEST certifies that no party to this application has been denied the FCC benefits pursuant to Section 5301 of the Anti-Drug Abuse Act of 1988, 21 U.S.C. 862.



Randy Ortanez
President



| | | | | |
|--|--|---|--|--|
| FCC ID: A3LSGHT249 | | HAC (RF EMISSIONS) TEST REPORT | | Reviewed by: Quality Manager |
| HAC Filename: OY1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 1 of 74 |

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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- RF Magnetic-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:



- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. TEST SITE LOCATION

2.1 INTRODUCTION

The map at the right shows the location of the PCTEST LABORATORY in Columbia, Maryland. It is in proximity to the FCC Laboratory, the Baltimore-Washington International (BWI) airport, the city of Baltimore and Washington, DC (See Figure 2).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49' 38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4 on January 27, 2006 and Industry Canada.



Figure 2-1
Map of the Greater Baltimore and Metropolitan Washington D.C. area

2.2 Test Facility / Accreditations:

Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.



- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing-Aid Compatibility (HAC), CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and all Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS and CDMA, and EvDO mobile phones.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO Data, CDMA 1xRTT Data.



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3. EUT DESCRIPTION



FCC ID: A3LSGHT249
Manufacturer: Samsung Electronics, Co. Ltd.
 18600 Broadwick St.
 Rancho Dominguez, CA 90220
 United States
Trade Name: Samsung
Model(s): SGH-T249
Serial Number: FH-152-C
Tx Frequencies: 824.20 - 848.80 MHz (GSM 850)
 1850.20 - 1909.80 MHz (GSM 1900)
Antenna Configurations: Internal Antenna
Maximum Conducted Power (EMC/SAR): 32.10 dBm (GSM 850), 29.89dBm (GSM 1900)
Maximum Conducted Power (HAC): 32.10 dBm (GSM 850), 29.89dBm (GSM 1900)
HAC Test Configurations: GSM 850, 128, 190, 251, BT Off, Slide Out
 GSM 1900, 512, 661, 810, BT Off, Slide Out
FCC Classification: Licensed Transmitter Held to Ear (PCE)
EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth

Note: Slide Out configuration is maximum antenna RF efficiency. Therefore Slide Out only is tested per C63.19 Section 4.3.3

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4. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES



I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

| Category | Telephone RF Parameters | |
|--|------------------------------------|------------------------------------|
| Near field Category | E-field emissions CW dB(V/m) | H-field emissions CW dB(A/m) |
| f < 960 MHz | | |
| M1 | 56 to 61 + 0.5 x AWF | 5.6 to 10.6 +0.5 x AWF |
| M2 | 51 to 56 + 0.5 x AWF | 0.6 to 5.6 +0.5 x AWF |
| M3 | 46 to 51 + 0.5 x AWF | -4.4 to 0.6 +0.5 x AWF |
| M4 | < 46 + 0.5 x AWF | < -4.4 + 0.5 x AWF |
| f > 960 MHz | | |
| M1 | 46 to 51 + 0.5 x AWF | -4.4 to 0.6 +0.5 x AWF |
| M2 | 41 to 46 + 0.5 x AWF | -9.4 to -4.4 +0.5 x AWF |
| M3 | 36 to 41 + 0.5 x AWF | -14.4 to -9.4 +0.5 x AWF |
| M4 | < 36 + 0.5 x AWF | < -14.4 + 0.5 x AWF |
| Table 4-1 Hearing aid and WD near-field categories as defined in ANSI C63.19-2007 v3.12 [2] | | |

II. ARTICULATION WEIGHTING FACTOR (AWF)

| Standard | Technology | Articulation Weighing Factor (AWF) |
|--|---------------------|------------------------------------|
| T1/T1P1/3GPP | UMTS (WCDMA) | 0 |
| IS-95 | CDMA | 0 |
| iDEN™ | TDMA (22 and 11 Hz) | 0 |
| J-STD-007 | GSM (217 Hz) | -5 |
| Table 4-2 Articulation Weighing Factors | | |

| | | | | |
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5. SYSTEM SPECIFICATIONS

ER3DV6 E-Field Probe Description

| | |
|---------------|--|
| Construction: | One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges |
| Calibration: | In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$) |
| Frequency: | 100 MHz to > 6 GHz; Linearity: ± 0.2 dB (100 MHz to 3 GHz) |
| Directivity | ± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis) |
| Dynamic Range | 2 V/m to > 1000 V/m (M3 or better device readings fall well below diode compression point) |
| Linearity: | ± 0.2 dB |
| Dimensions | Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm |



Figure 5-1
E-field Free-space Probe

H3DV6 H-Field Probe Description

| | |
|-----------------------|---|
| Construction: | Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges |
| Frequency: | 200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$, $k=2$); Output linearized |
| Directivity: | ± 0.25 dB (spherical isotropy error) |
| Dynamic Range: | 10 mA/m to 2 A/m at 1 GHz (M3 or better device readings fall well below diode compression point) |
| Dimensions: | Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm |
| E-Field Interference: | < 10% at 3 GHz (for plane wave) |





Figure 5-2
H-Field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

Magnetic field sensors are measuring the integral of the H-field across their sensor area surrounded by the loop. They are calibrated in a precise, homogeneous field. When measuring a gradient field, the result will be very close to the field in the center of the loop which is equivalent to the value of a homogeneous field equivalent to the center value. But it will be different from the field at the border of the loop.

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Consequently, two sensors with different loop diameters - both calibrated ideally - would give different results when measuring from the edge of the probe sensor elements. The behavior for electrically small E-field sensors is equivalent.

The magnetic field loops of the H3D probes are concentric, with the center 3mm from the tip for H3DV6. Their radius is 1.9mm.

The electric field probes have a more irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.



The antistatic shielding inside the probe is connected to the probe connector case.

Instrumentation Chain

Equation 1

Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF) / (DCP)}{Norm_i \cdot ConvF}}$$

whereby

- E_i : electric field in V/m
- u_i : voltage of channel i at the connector in μV
- $Norm_i$: sensitivity of channel i in $\mu V / (V/m)^2$
- $ConvF$: enhancement factor in liquid (ConvF=1 for Air)
- DCP : diode compression point in μV
- CF : signal crest factor (peak power/average power)

Conditions of Calibration



Please note:

- a lower input impedance of the amplifier will result in different sensitivity factors $Norm_i$ and DCP
- larger bias currents will cause higher offset

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Probe Response to Frequency

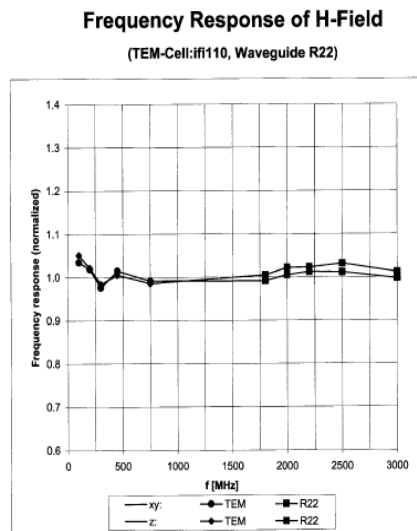
The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Figure 5-3 E-Field Probe Frequency Response

H-field sensors have a frequency dependent sensitivity which is evaluated for a series of frequencies also visible in the probe calibration certificate. The calibration factors result from a fitting algorithm. The proper conversion is calculated by the DASY4 software depending on the frequency setting in the procedure. See below for H-field frequency response:



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Figure 5-4 H-Field Probe Frequency Response

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Conversion to Peak

Peak is defined as Peak Envelope Power. All raw measurements from the HAC measurement system are RMS values. The DASY4 system incorporates the crest factor of the signal in the computation of the RMS values (See Equation 1). Although the software also has capability to estimate the peak field by applying a square root of crest factor value to the readings, the probe modulation factor was applied manually instead per C63.19 in the measurement tables in this report. The equation to convert the raw measurements in the data tables are:

$$\text{Peak Field} = 20 \cdot \log (\text{Raw} \cdot \text{PMF})$$

Where:

Peak Field = Peak field (in dBV/m or dBA/m)

Raw = Raw field measurement from the measurement system (in V/m or A/m).

PMF = Probe Modulation Factor (in linear units).

SPEAG Robotic System



E-field and H-field measurements are performed using the DASY4 automated dosimetric assessment system. The DASY4 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Pentium 4 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 5-5
SPEAG Robotic System

System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the Gateway Pentium 4 2.53 GHz computer with Windows XP system and RF Measurement Software DASY4 v4.5 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

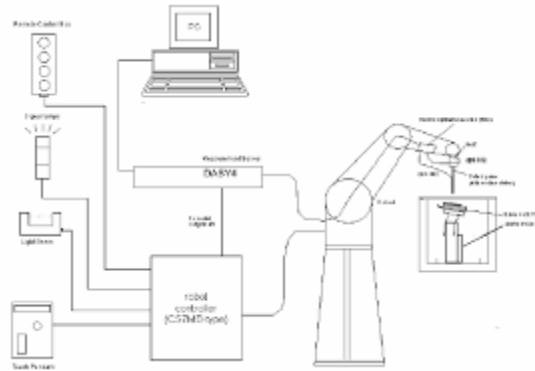




Figure 5-6
SPEAG Robotic System Diagram

DASY4 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

| | | | |
|------|---------|-----------------------------------|------------------|
| with | V_i | = compensated signal of channel i | (i = x, y, z) |
| | U_i | = input signal of channel i | (i = x, y, z) |
| | cf | = crest factor of exciting field | (DASY parameter) |
| | dcp_i | = diode compression point | (DASY parameter) |

| | | | | |
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From the compensated input signals the primary field data for each channel can be evaluated:

$$\begin{aligned} \text{E - fieldprobes :} \quad E_i &= \sqrt{\frac{V_i}{Norm_i \cdot ConvF}} \\ \text{H - fieldprobes :} \quad H_i &= \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f} \end{aligned}$$

with V_i = compensated signal of channel i (i = x, y, z)
 $Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
 $\mu\text{V}/(\text{V}/\text{m})^2$ for E-field Probes
 $ConvF$ = sensitivity enhancement in solution
 a_{ij} = sensor sensitivity factors for H-field probes
 f = carrier frequency [GHz]
 E_i = electric field strength of channel i in V/m
 H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):



$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500 ms.

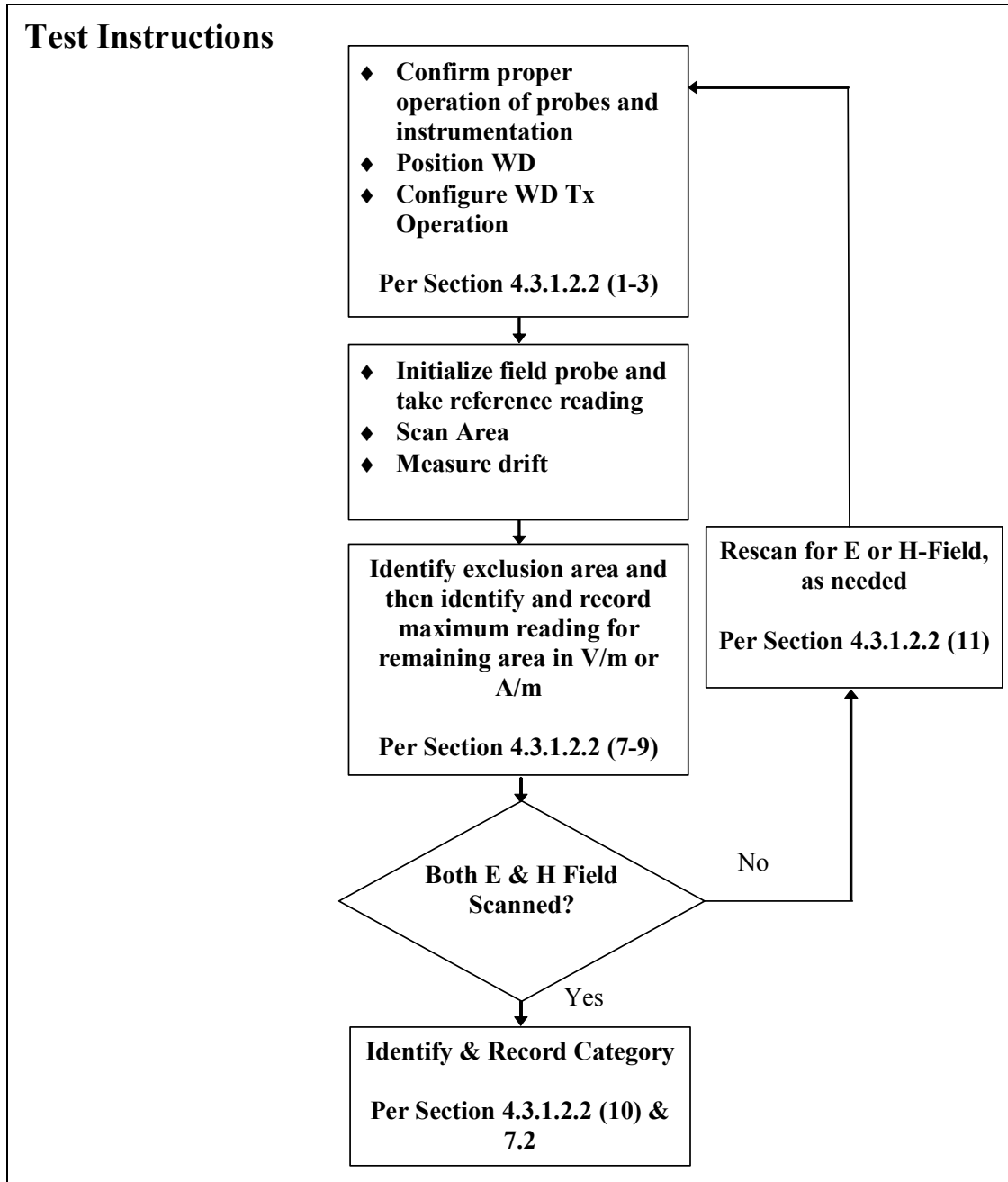
The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500 ms and a probe response time of <5 ms. In the current implementation, DASY4 waits longer than 100 ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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6. TEST PROCEDURE

I. RF EMISSIONS



| | | | | |
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Test Setup



Figure 6-1

E/H-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)

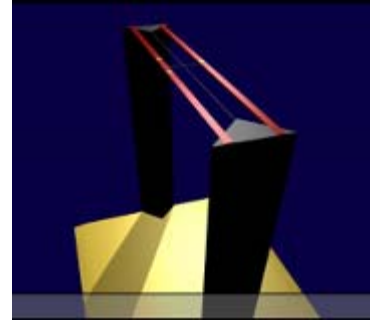




Figure 6-2
HAC Phantom

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
6. The measurement system measured the field strength at the reference location.
7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
8. The system performed a drift evaluation by measuring the field at the reference location.
9. Steps 1-8 were done for both the E and H-Field measurements.

| | | | | |
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7. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power $P = 100\text{mW RMS}$ (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:

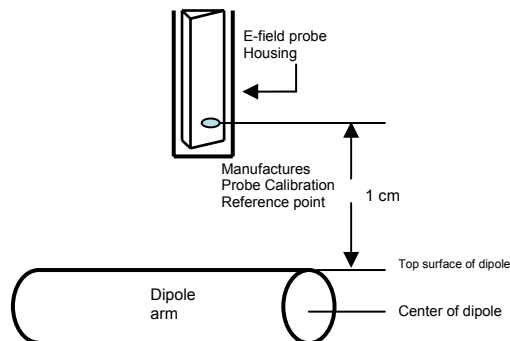


Figure 7-1
Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

The length of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (

| | | | | |
|-----------------------------------|--|--|---------|---------------------------------|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 15 of 74 |

see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

RF power was recorded using both an average and a peak power reading meter.



Figure 7-2

Setup for Desired Output Power to Dipole

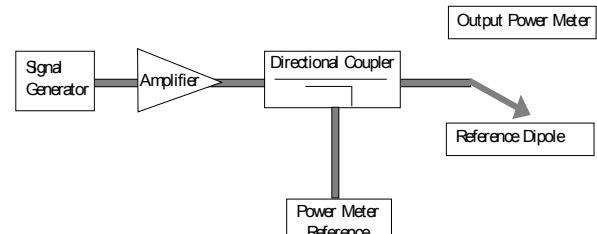


Figure 7-3

Setup to Dipole

Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 7-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:

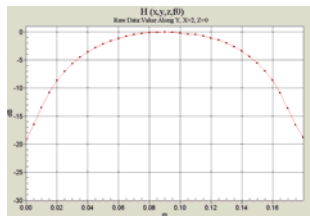


Figure 7-4

2-D Raw Data from scan along dipole axis

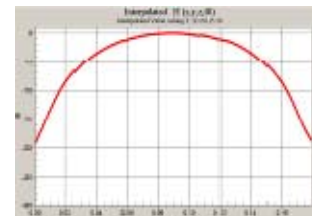


Figure 7-5

2-D Interpolated points from scan along dipole axis

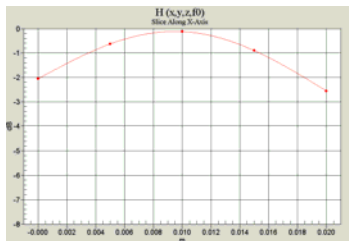


Figure 7-6

2-D Raw Data from scan along transverse axis

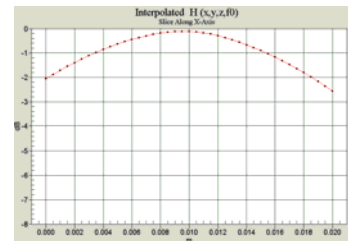


Figure 7-7

2-D Interpolated points from scan along transverse axis

| | | | | |
|-----------------------------------|--|--|---------|---------------------------------|
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III. System Check Results

Validation Results

| Frequency (MHz) | Input Power (dBm) | E-field Result (V/m) | Target Field (V/m) | % Deviation |
|-----------------|-------------------|----------------------|--------------------|-------------|
| 835 | 20.0 | 164.5 | 163.2 | 0.8% |
| 1880 | 20.0 | 149.4 | 137.2 | 8.9% |
| Frequency (MHz) | Input Power (dBm) | H-field Result (A/m) | Target Field (A/m) | % Deviation |
| 835 | 20.0 | 0.445 | 0.440 | 1.1% |
| 1880 | 20.0 | 0.478 | 0.460 | 4.0% |

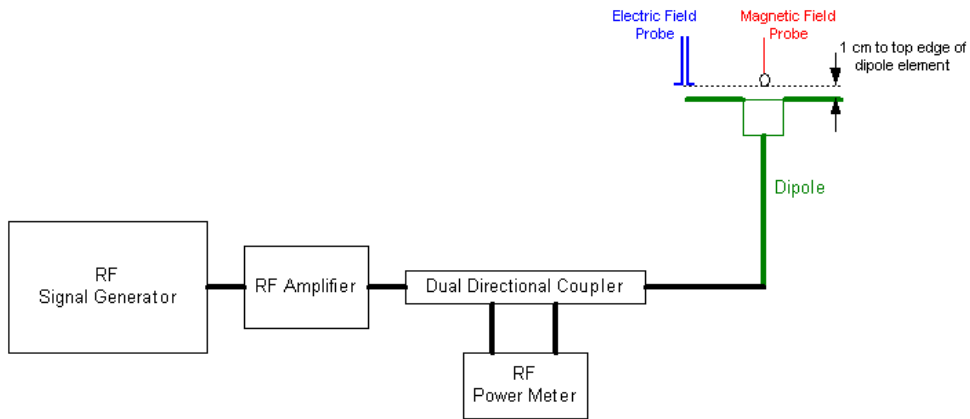


Figure 7-8
System Check Setup

| | | | | |
|-----------------------------------|--|--|---------|---------------------------------|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
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8. MODULATION FACTOR

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals are ensured to be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements.

All voice modes for this device have been investigated in this section of the report.

This was done using the following procedure:

1. The probe was illuminated with a CW signal at the intended measurement frequency and wireless device power.
2. The probe was positioned at the field maxima over the dipole antenna (determined after an area scan over the dipole) illuminated with the CW signal.
3. The reading of the probe measurement system of the CW signal at the maximum point was recorded.
4. Using a Spectrum Analyzer, the modulated signal adjusted with the same peak level of the CW signal was determined.
5. The probe measurement system reading was recorded with the modulated signal. The appropriate system crest factors for the modulation type were configured in the software to the system measurements.
6. The ratio of the CW reading to modulated signal reading is the probe modulation factor (PMF) for the modulation and field probe combination. This was repeated for 80% AM.
7. Steps 1-6 were repeated at all frequency bands and for both E and H field probes.



The modulation factors obtained were applied to readings taken of the actual wireless device, in order to obtain an accurate peak field reading using the formula:

$$\text{Peak} = 20 \cdot \log (\text{Raw} \cdot \text{PMF})$$

Modulation Factors:

| f (MHz) | Protocol | E-Field (V/m) | H-Field (A/m) | E-Field Modulation Factor | H-Field Modulation Factor |
|---------|----------|---------------|---------------|---------------------------|---------------------------|
| 835 | AM | 629.3 | 2.212 | 1.290 | 0.910 |
| 835 | GSM | 287 | 1.033 | 2.829 | 1.948 |
| 835 | CW | 811.8 | 2.012 | | |
| 1880 | AM | 390.8 | 1.215 | 1.319 | 1.115 |
| 1880 | GSM | 184.8 | 0.5843 | 2.790 | 2.319 |
| 1880 | CW | 515.6 | 1.355 | | |

Figure 8-1
Modulation Factors

| | | | | |
|-----------------------------------|--|--|---|---------------------------------|
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Spectrum Analyzer Plots of ESG-D Signal used for PMF measurements:

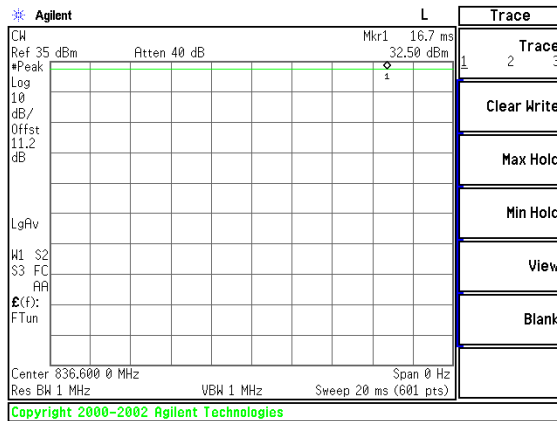


Figure 8-2 GSM850 CW Signal

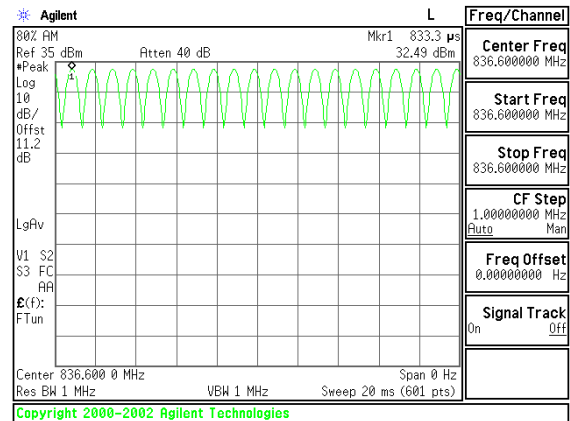


Figure 8-3 GSM850 80% AM Signal

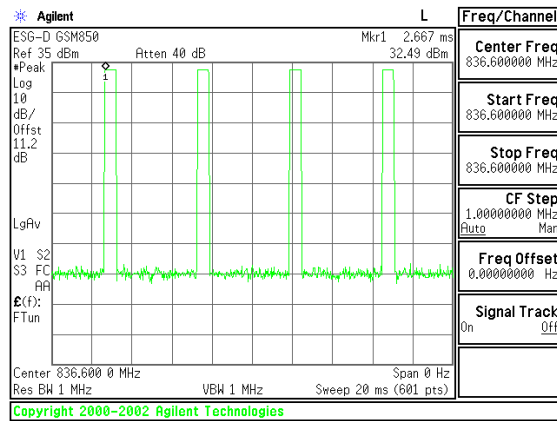


Figure 8-4 GSM850 Signal

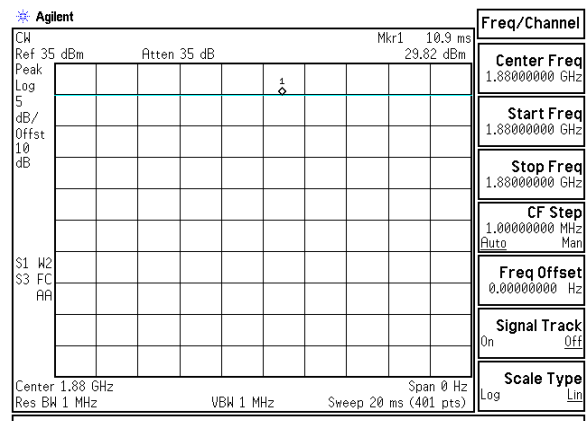


Figure 8-5 PCS CW Signal

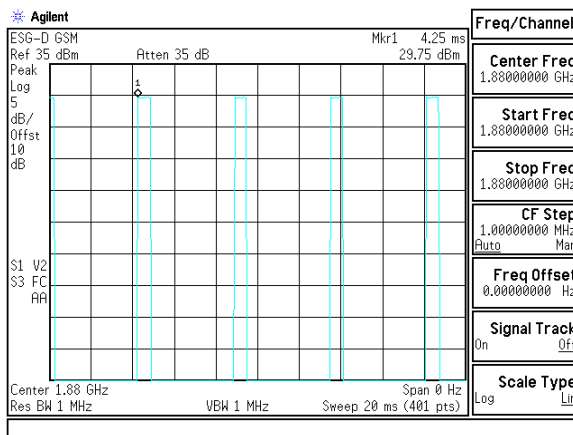


Figure 8-6 PCS GSM Signal

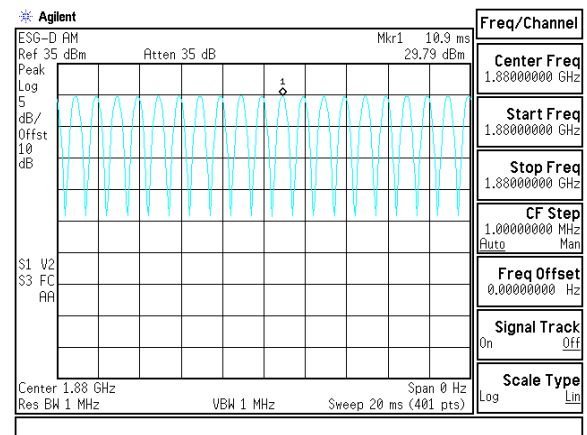


Figure 8-7 PCS 80% AM Signal

| | | | |
|--|--|---|--|
| FCC ID: A3LSGHT249 | PCTEST <small>ENGINEERING LABORATORY, INC.</small> | HAC (RF EMISSIONS) TEST REPORT | |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Reviewed by: Quality Manager |
| Page 19 of 74 | | | REV 8.2G 04/05/20 |

9. OVERALL MEASUREMENT SUMMARY

| | |
|----------------|------------|
| FCC ID: | A3LSGHT249 |
| Model: | SGH-T249 |
| S/N: | FH-152-C |

I. E-FIELD EMISSIONS:

**Table 9-1
HAC Data Summary for E-field**

| Mode | Channel | Backlight | Talk Config | Scan Center | Conducted Power at BS (dBm) | Time Avg. Field (V/m) | Peak Field (dBV/m) | FCC Limit (dBV/m) | FCC MARGIN (dB) | RESULT | Excl Blocks per 4.4 |
|--------------------------|---------|-----------|-------------|-------------|-----------------------------|-----------------------|--------------------|-------------------|-----------------|--------|---------------------|
| E-field Emissions | | | | | | | | | | | |
| GSM850 | 128 | off | Slide Out | Acoustic | 31.99 | 81.91 | 47.30 | 48.50 | -1.20 | M3 | none |
| GSM850 | 190 | off | Slide Out | Acoustic | 32.07 | 72.85 | 46.28 | 48.50 | -2.22 | M3 | none |
| GSM850 | 251 | off | Slide Out | Acoustic | 32.10 | 74.22 | 46.44 | 48.50 | -2.06 | M3 | none |
| GSM1900 | 512 | off | Slide Out | Acoustic | 29.89 | 22.33 | 35.89 | 38.50 | -2.61 | M3 | none |
| GSM1900 | 661 | off | Slide Out | Acoustic | 29.44 | 19.79 | 34.84 | 38.50 | -3.66 | M3 | none |
| GSM1900 | 810 | off | Slide Out | Acoustic | 29.35 | 19.20 | 34.58 | 38.50 | -3.92 | M3 | none |
| GSM850 | 128 | off | Slide Out | T-coil | 31.99 | 81.91 | 47.30 | 48.50 | -1.20 | M3 | none |

Note: Slide Out configuration is maximum antenna RF efficiency. Therefore Slide Out only is tested per C63.19 Section 4.3.3

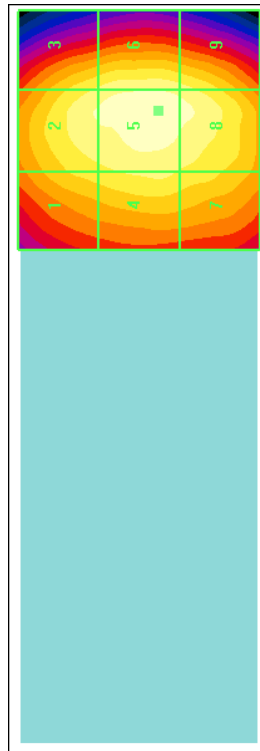




Figure 9-1
Sample E-field Scan Overlay
(See Test Setup Photographs for actual WD overlay)

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 20 of 74 | |

| | |
|----------------|------------|
| FCC ID: | A3LSGHT249 |
| Model: | SGH-T249 |
| S/N: | FH-152-C |

II. H-FIELD EMISSIONS:

**Table 9-2
HAC Data Summary for H-field**

| Mode | Channel | Backlight | Talk Config | Scan Center | Conducted Power at BS (dBm) | Time Avg. Field (A/m) | Peak Field (dBA/m) | FCC Limit (dBA/m) | FCC MARGIN (dB) | RESULT | Excl Blocks per 4.4 |
|--------------------------|---------|-----------|-------------|-------------|-----------------------------|-----------------------|--------------------|-------------------|-----------------|--------|---------------------|
| H-field Emissions | | | | | | | | | | | |
| GSM850 | 128 | off | Slide Out | Acoustic | 31.99 | 0.1584 | -10.2 | -1.9 | -8.31 | M4 | none |
| GSM850 | 190 | off | Slide Out | Acoustic | 32.07 | 0.1358 | -11.6 | -1.9 | -9.65 | M4 | none |
| GSM850 | 251 | off | Slide Out | Acoustic | 32.10 | 0.1401 | -11.3 | -1.9 | -9.38 | M4 | none |
| GSM1900 | 512 | off | Slide Out | Acoustic | 29.89 | 0.0551 | -17.9 | -11.9 | -5.98 | M4 | none |
| GSM1900 | 661 | off | Slide Out | Acoustic | 29.44 | 0.0542 | -18.0 | -11.9 | -6.11 | M4 | none |
| GSM1900 | 810 | off | Slide Out | Acoustic | 29.35 | 0.0576 | -17.5 | -11.9 | -5.59 | M4 | none |

Note: Slide Out configuration is maximum antenna RF efficiency. Therefore Slide Out only is tested per C63.19 Section 4.3.3

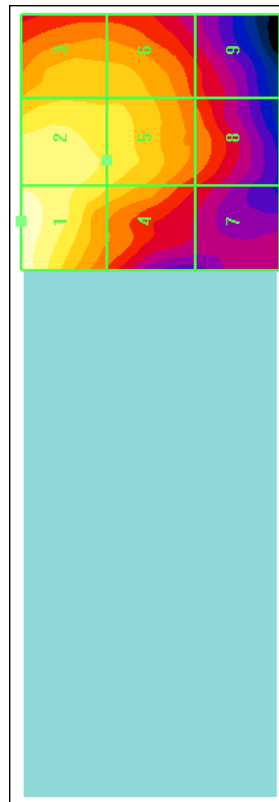




Figure 9-2
Sample H-field Scan Overlay
(See Test Setup Photographs for actual WD overlay)

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
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| | |
|---------|------------|
| FCC ID: | A3LSGHT249 |
| Model: | SGH-T249 |
| S/N: | FH-152-C |

III. Worst-case Configuration Evaluation

Table 9-3
Peak Reading 360° Probe Rotation at Azimuth axis

| Mode | Channel | Backlight | Talk Config | Scan Center | Time Avg. Field (V/m) | Peak Field (dBV/m) | FCC Limit (dBV/m) | FCC MARGIN (dB) | RESULT |
|-------------------------------------|---------|-----------|-------------|-------------|-----------------------|--------------------|-------------------|-----------------|--------|
| Probe Rotation at Worst-Case | | | | | | | | | |
| GSM850 | 128 | off | Slide Out | Acoustic | 82.50 | 47.36 | 48.50 | -1.14 | M3 |

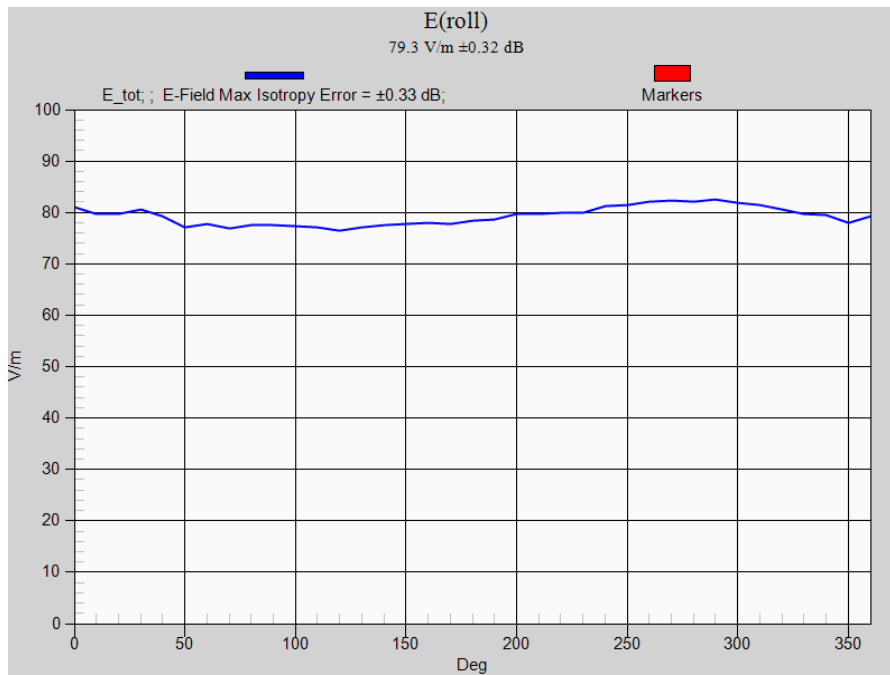




Figure 9-3
Worst-Case Probe Rotation about Azimuth axis

* Note: Location of probe rotation is shown in Figure 9-1 or Figure 9-2



| | | | | |
|-----------------------------------|--|--|---|---------------------------------|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  SAMSUNG | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 22 of 74 | |

10. EQUIPMENT LIST

Table 10-1
Equipment List

| Manufacturer | Model | Description | Cal Date | Cal Interval | Cal Due | Serial Number |
|-----------------|----------|-----------------------------------|-----------|--------------|-----------|---------------|
| Agilent | E5515C | Wireless Communications Test Set | 8/25/2009 | Annual | 8/25/2010 | GB41450275 |
| Agilent | E4432B | ESG-D Series Signal Generator | 9/10/2009 | Annual | 9/10/2010 | US40053896 |
| Agilent | E5515C | Wireless Communications Test Set | 9/10/2009 | Annual | 9/10/2010 | GB46110872 |
| Agilent | E5515C | Wireless Communications Test Set | 9/11/2009 | Annual | 9/11/2010 | GB46310798 |
| Agilent | E4407B | ESA Spectrum Analyzer | 3/30/2010 | Annual | 3/30/2011 | US39210313 |
| Agilent | E5515C | Wireless Communications Tester | 4/14/2010 | Annual | 4/14/2011 | US41140256 |
| Agilent | 8648D | (9kHz-4GHz) Signal Generator | 9/19/2009 | Biennial | 9/19/2011 | 3613A00315 |
| Rohde & Schwarz | NRVD | Dual Channel Power Meter | 8/20/2008 | Biennial | 8/20/2010 | 101695 |
| Rohde & Schwarz | CMU200 | Base Station Simulator | 9/4/2009 | Annual | 9/4/2010 | 109892 |
| Rohde & Schwarz | NRV-Z32 | Peak Power Sensor (100uW-2W) | 12/5/2008 | Biennial | 12/5/2010 | 100155 |
| Rohde & Schwarz | NRV-Z33 | Peak Power Sensor (1mW-20W) | 12/5/2008 | Biennial | 12/5/2010 | 100004 |
| Rohde & Schwarz | CMU200 | Base Station Simulator | 6/21/2010 | Annual | 6/21/2011 | 833855/0010 |
| SPEAG | DAE3 | Dasy Data Acquisition Electronics | 9/17/2009 | Annual | 9/17/2010 | 455 |
| SPEAG | ER3DV6 | Freespace E-field Probe | 1/8/2010 | Annual | 1/8/2011 | 2353 |
| SPEAG | H3DV6 | Freespace H-field Probe | 1/8/2010 | Annual | 1/8/2011 | 6207 |
| SPEAG | CD835V3 | Freespace 835 MHz Dipole | 1/14/2009 | Biennial | 1/14/2011 | 1003 |
| SPEAG | CD1880V3 | Freespace 1880 MHz Dipole | 1/21/2009 | Biennial | 1/21/2011 | 1002 |
| SPEAG | DAE4 | Dasy Data Acquisition Electronics | 1/22/2010 | Annual | 1/22/2011 | 649 |
| SPEAG | DAE4 | Dasy Data Acquisition Electronics | 3/22/2010 | Annual | 3/22/2011 | 704 |
| SPEAG | DAE4 | Dasy Data Acquisition Electronics | 4/21/2010 | Annual | 4/21/2011 | 665 |
| Speag | CD1880V3 | Freespace 1880 MHz Dipole | 4/7/2010 | Biennial | 4/7/2012 | 1137 |
| SPEAG | CD1880V3 | Freespace 1880 MHz Dipole | 6/16/2010 | Biennial | 6/16/2012 | 1064 |

*Calibration traceable to the National Institute of Standards and Technology (NIST).

| | | | | |
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11. MEASUREMENT UNCERTAINTY



| Wireless Communications Device Near-Field Measurement | | | | | | | | |
|---|-----------|-----------|-------------|---------|--------|--------|-------------|----------------|
| Uncertainty Estimation | | | | | | | | |
| Uncertainty Component | Data (dB) | Data Type | Prob. Dist. | Divisor | Ci (E) | Ci (H) | Unc. (dB) | Notes/Comments |
| Measurement System | | | | | | | | |
| RF System Reflections | 0.50 | Tolerance | N | 1.00 | 1 | 1 | 0.50 | Refl. < -20 dB |
| Field Probe Calibration | 0.21 | Tolerance | N | 1.00 | 1 | 1 | 0.21 | |
| Field Probe Isotropy | 0.01 | Tolerance | N | 1.00 | 1 | 1 | 0.01 | |
| Field Probe Frequency Response | 0.135 | Tolerance | N | 1.00 | 1 | 1 | 0.14 | |
| Field Probe Linearity | 0.013 | Tolerance | N | 1.00 | 1 | 1 | 0.01 | |
| Probe Modulation Factor | 0.270 | Accuracy | R | 1.73 | 1 | 1 | 0.16 | |
| Boundary Effects | 0.105 | Accuracy | R | 1.73 | 1 | 1 | 0.06 | * |
| Probe Positioning Accuracy | 0.20 | Accuracy | R | 1.73 | 1 | 0.670 | 0.12 | * |
| Probe Positioner | 0.050 | Accuracy | R | 1.73 | 1 | 0.670 | 0.03 | * |
| Extrapolation/Interpolation | 0.045 | Tolerance | R | 1.73 | 1 | 1 | 0.03 | * |
| Resolution to 2mm error | 0.210 | Tolerance | N | 1.00 | 1 | 1 | 0.21 | |
| System Detection Limit | 0.05 | Tolerance | R | 1.73 | 1 | 1 | 0.03 | * |
| Readout Electronics | 0.015 | Tolerance | N | 1.00 | 1 | 1 | 0.02 | * |
| Integration Time | 0.11 | Tolerance | R | 1.73 | 1 | 1 | 0.06 | * |
| Response Time | 0.033 | Tolerance | R | 1.73 | 1 | 1 | 0.02 | * |
| Phantom Thickness | 0.10 | Tolerance | R | 1.73 | 1 | 1 | 0.06 | * |
| System Repeatability (Field x 2=power) | 0.17 | Tolerance | N | 1.00 | 1 | 1 | 0.17 | |
| Test Sample Related | | | | | | | | |
| Device Positioning Vertical | 0.2 | Tolerance | R | 1.73 | 1 | 1 | 0.12 | * |
| Device Positioning Lateral | 0.045 | Tolerance | R | 1.73 | 1 | 1 | 0.03 | * |
| Device Holder and Phantom | 0.1 | Tolerance | R | 1.73 | 1 | 1 | 0.06 | * |
| Power Drift | 0.21 | Tolerance | R | 1.73 | 1 | 1 | 0.12 | |
| Combined Standard Uncertainty (k=1) | | | | | | | 0.66 | 16.5% |
| Expanded Uncertainty [95% confidence] (k=2) | | | | | | | 1.33 | 32.3% |
| Expanded Uncertainty [95% confidence] on Field | | | | | | | 0.66 | 16.2% |

Table 11-1
Uncertainty Estimation Table

Notes:



1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.
2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

| | | | | |
|-----------------------------------|---|--|---|---------------------------------|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 24 of 74 | |

12. TEST DATA

See following Attached Pages for Test Data.

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
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PCTEST Hearing-Aid Compatibility Facility

DUT: CD835V3 - SN1003

Type: CD835V3
Serial: 1003

Communication System: CW; Frequency: 835 MHz;

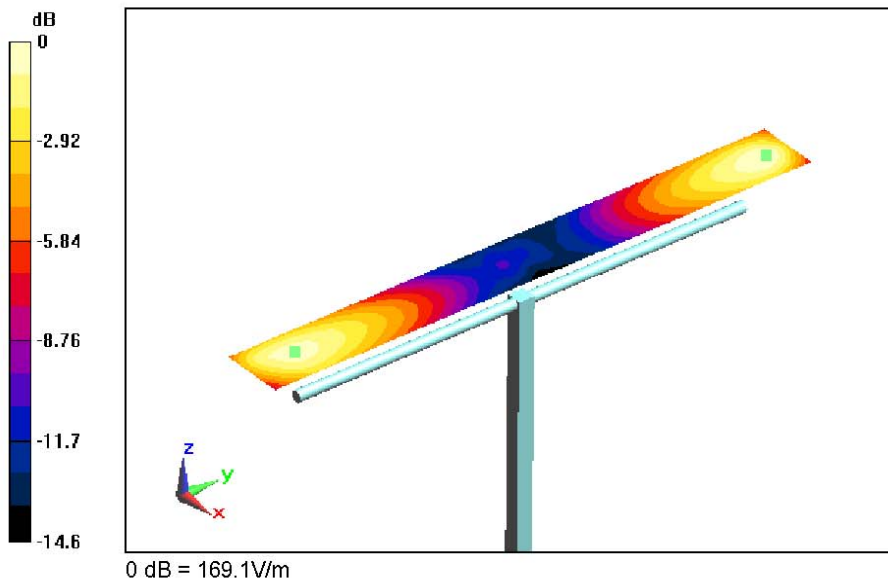
Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 1/8/2010
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

835 MHz / 100mW HAC Dipole Validation at 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm
 Probe Modulation Factor = 1
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 94.1 V/m; Power Drift = 0.100 dB
 Average value of Total (interpolated) = 164.5 V/m



2010 PCTEST

| | | | | |
|-----------------------------------|--|--|---------------|---------------------------------|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 26 of 74 | |



PCTEST Hearing-Aid Compatability Facility

DUT: CD835V3 - SN1003

Type: CD835V3
Serial: 1003

Communication System: CW; Frequency: 835 MHz;

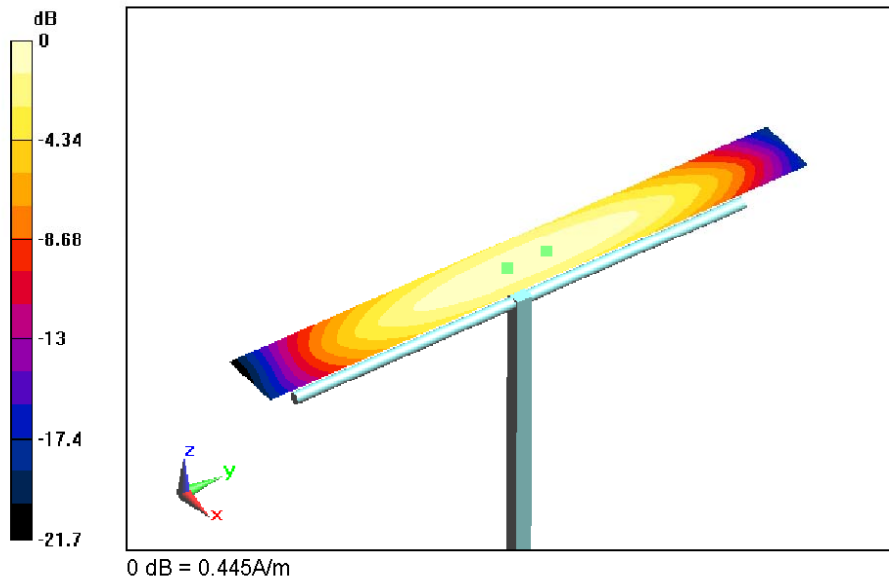
Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: H3DV6 - SN6207; Calibrated: 1/8/2010
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS, V5.0 Build 125;

835 MHz / 100 mW HAC Validation at 10 mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm
 Probe Modulation Factor = 1
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 0.467 A/m; Power Drift = -0.051 dB
 Maximum value of Total (interpolated) = 0.445 A/m



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|---|---|--|---|
| <p>FCC ID: A3LSGHT249</p> | | <p>HAC (RF EMISSIONS) TEST REPORT</p> | <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 27 of 74</p> |



PCTEST Hearing-Aid Compatibility Facility

DUT: CD1880V3 - SN1002

Type: CD1880V3
Serial: 1002

Communication System: CW; Frequency: 1880 MHz;

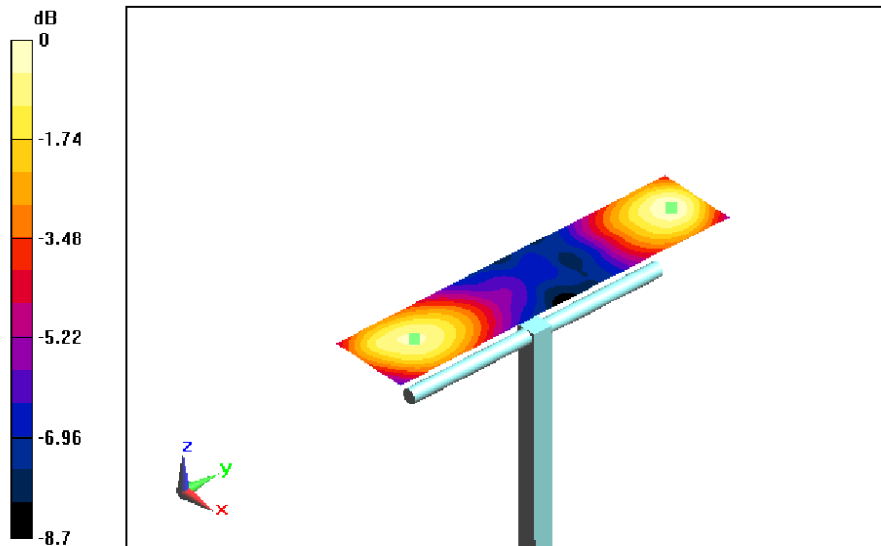
Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 1/8/2010
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, v5.0 Build 125;

1880 MHz / 100mW HAC Dipole Validation at 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm
 Probe Modulation Factor = 1
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 176.5 V/m; Power Drift = -0.017 dB
 Average value of Total (interpolated) = 149.4 V/m



0 dB = 153.4V/m

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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 28 of 74 | |



PCTEST Hearing-Aid Com patability Facility

DUT: CD1880V3 - SN1002

Type: CD1880V3
Serial: 1002

Communication System: CW; Frequency: 1880 MHz;

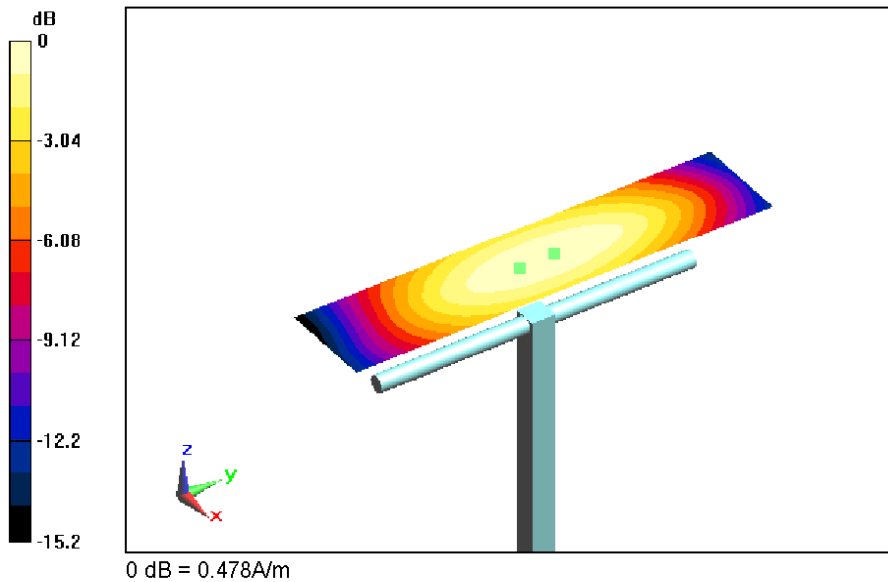
Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: H3DV6 - SN6207; Calibrated: 1/8/2010
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS, V5.0 Build 125;

1880 MHz / 100 mW HAC Validation at 10 mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm
Probe Modulation Factor = 1
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 0.512 A/m; Power Drift = -0.084 dB
Maximum value of Total (interpolated) = 0.478 A/m



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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 29 of 74 | |



PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSGHT249

Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth
 Serial: FH-152-C
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM850; Frequency: 824.2 MHz;

Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 1/8/2010
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS, V5.0 Build 125;

GSM850 Low Channel, Slide Out/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm
 Maximum value of peak Total field = 231.7 V/m
 Probe Modulation Factor = 2.83
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 108.2 V/m; Power Drift = -0.055 dB
Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

| | | |
|-----------------|-----------------|-----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 204.9 M3 | 221.3 M3 | 211.0 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 212.5 M3 | 231.7 M3 | 219.5 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 207.6 M3 | 225.0 M3 | 214.5 M3 |



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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 30 of 74 | |



PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSGHT249

Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth
 Serial: FH-152-C
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM850; Frequency: 824.2 MHz;

Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: H3DV6 - SN6207; Calibrated: 1/8/2010
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS, V5.0 Build 125;

GSM850 Low Channel, Slide Out/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm
 Maximum value of peak Total field = 0.309 A/m
 Probe Modulation Factor = 1.95
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 0.091 A/m; Power Drift = -0.121 dB
Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

| | | |
|-----------------|-----------------|-----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 0.309 M4 | 0.210 M4 | 0.129 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.309 M4 | 0.212 M4 | 0.136 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.308 M4 | 0.213 M4 | 0.140 M4 |



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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 31 of 74 | |



PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSGHT249

Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth
 Serial: FH-152-C
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM1900; Frequency: 1850.2 MHz;

Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 1/8/2010
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

GSM1900 Low Channel, Slide Out/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm
 Maximum value of peak Total field = 62.3 V/m
 Probe Modulation Factor = 2.79
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 9.41 V/m; Power Drift = -0.178 dB
Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

| | | |
|----------------|----------------|----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 62.3 M3 | 57.7 M3 | 50.6 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 38.6 M4 | 40.4 M4 | 40.4 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 59.8 M3 | 59 M3 | 52.3 M3 |



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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 32 of 74 | |



PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSGHT249

Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth
 Serial: FH-152-C
 Backlight off
 Duty Cycle: 1:8.3

Communication System: GSM1900; Frequency: 1909.8 MHz;

Measurement Standard: DASYS (IEEE/IEC)

DASY5 Configuration:

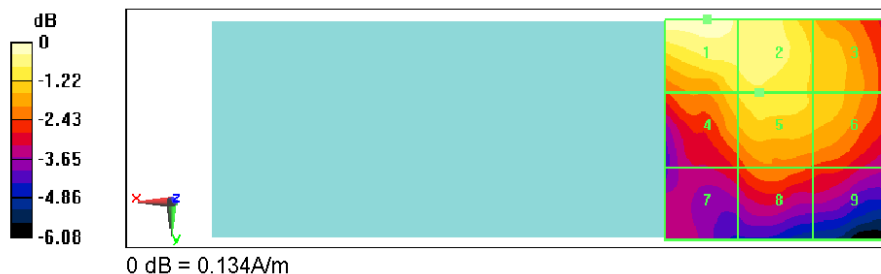
- Probe: H3DV6 - SN6207; Calibrated: 1/8/2010
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn455; Calibrated: 9/17/2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

GSM1900 High Channel, Slide Out/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm
 Maximum value of peak Total field = 0.134 A/m
 Probe Modulation Factor = 2.32
 Device Reference Point: 0, 0, -6.3 mm
 Reference Value = 0.051 A/m; Power Drift = 0.181 dB
Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

| | | |
|-----------------|-----------------|-----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 0.134 M4 | 0.128 M4 | 0.116 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.117 M4 | 0.121 M4 | 0.116 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.098 M4 | 0.106 M4 | 0.101 M4 |





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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 33 of 74 | |

13. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
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Calibration Laboratory of
 Schmid & Partner
 Engineering AG
 Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
 C Service suisse d'étalonnage
 S Servizio svizzero di taratura
 S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
 The Swiss Accreditation Service is one of the signatories to the EA
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client **PC Test**

Certificate No: **ER3-2353_Jan10**

CALIBRATION CERTIFICATE

Object: **ER3DV6 - SN:2353**

Calibration procedure(s): **QA CAL-02.v5 and QA CAL-25.v2
 Calibration procedure for E-field probes optimized for close near field
 evaluations in air**

Calibration date: **January 8, 2010**

*ok
 sz
 1/11/10*

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|--------------------------------|-----------------------|
| Power meter E4419B | GB41293874 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41495277 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41498087 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 31-Mar-09 (No. 217-01026) | Mar-10 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-09 (No. 217-01028) | Mar-10 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 31-Mar-09 (No. 217-01027) | Mar-10 |
| Reference Probe ER3DV6 | SN: 2328 | 3-Oct-09 (No. ER3-2328_Oct09) | Oct-10 |
| D4E4 | SN: 789 | 23-Dec-09 (No. D4E4-789_Dec09) | Dec-10 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---------------------------|--------------|-----------------------------------|------------------------|
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-09) | in house check: Oct-11 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-09) | in house check: Oct-10 |

| | Name | Function | Signature |
|----------------|---------------|-------------------|--------------------|
| Calibrated by: | Katja Pokovic | Technical Manager | <i>[Signature]</i> |
| Approved by: | Niels Kuster | Quality Manager | <i>[Signature]</i> |

Issued: January 8, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

| | | | | |
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Calibration Laboratory of
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Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Servizio svizzero di taratura
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Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary:

NORM_{x,y,z} sensitivity in free space
DCP diode compression point
CF crest factor (1/duty_cycle) of the RF signal
A, B, C modulation dependent linearization parameters
Polarization ϕ ϕ rotation around probe axis
Polarization ϑ ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center),
i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- *NORM_{x,y,z}*: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- *NORM(f)_{x,y,z}* = *NORM_{x,y,z}* * *frequency_response* (see Frequency Response Chart).
- *DCP_{x,y,z}*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}*: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- *Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORM_x* (no uncertainty required).

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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 36 of 74 | |



Probe ER3DV6

SN:2353

Manufactured: March 8, 2005
Last calibrated: July 17, 2008
Recalibrated: January 8, 2010

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

| | | | | |
|--|---|---|---|--|
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DASY - Parameters of Probe: ER3DV6 SN:2353**Basic Calibration Parameters**

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|--------------------------|----------|----------|----------|--------------|
| Norm ($\mu V/(V/m)^2$) | 1.56 | 1.76 | 1.88 | $\pm 10.1\%$ |
| DCP (mV) ^A | 94.7 | 94.4 | 94.9 | |



Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dBuV | C | VR mV | Unc ^E (k=2) |
|-------|---------------------------|------|---|---------|-----------|------|----------|---------------------------|
| 10000 | CW | 0.00 | X | 0.00 | 0.00 | 1.00 | 300 | $\pm 1.5\%$ |
| | | | Y | 0.00 | 0.00 | 1.00 | 300 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 300 | |

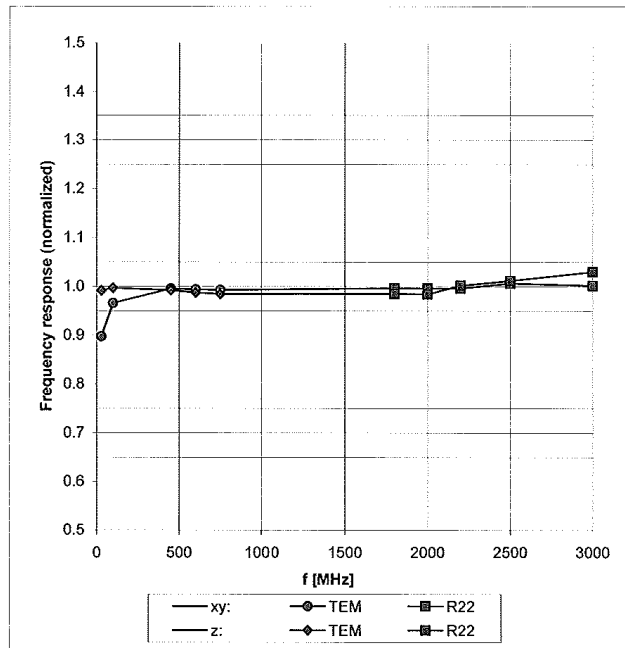
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A numerical linearization parameter; uncertainty not required



^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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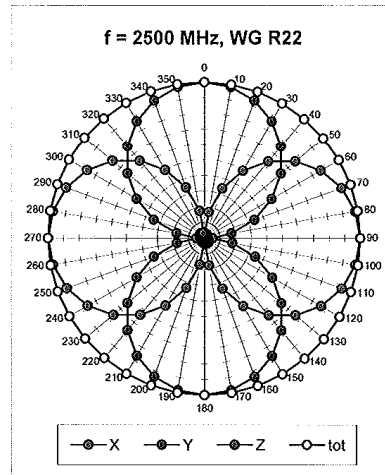
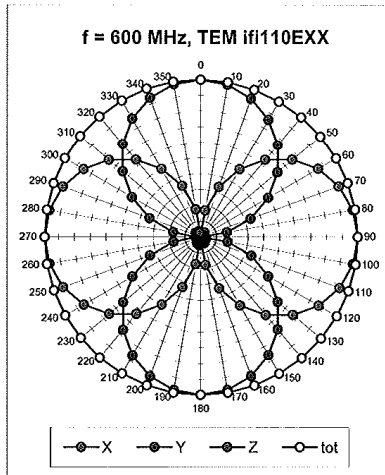
Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide R22)



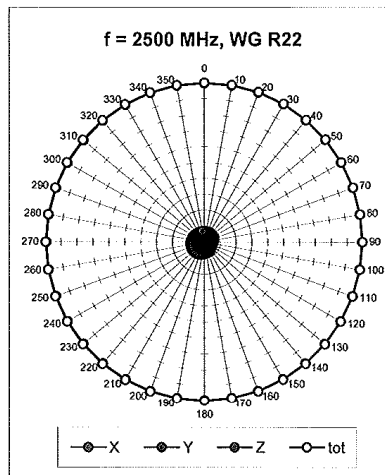
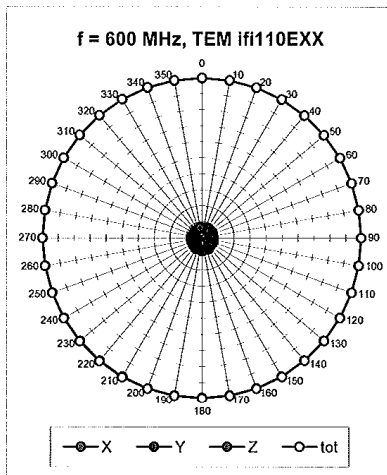
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)



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|--|---|---|--|
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Receiving Pattern (ϕ), $\vartheta = 0^\circ$

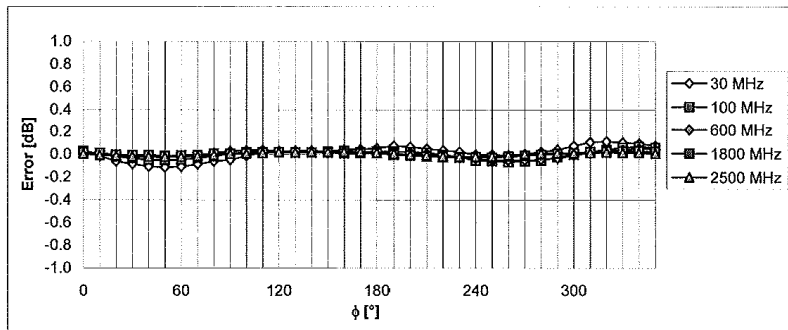


Receiving Pattern (ϕ), $\vartheta = 90^\circ$



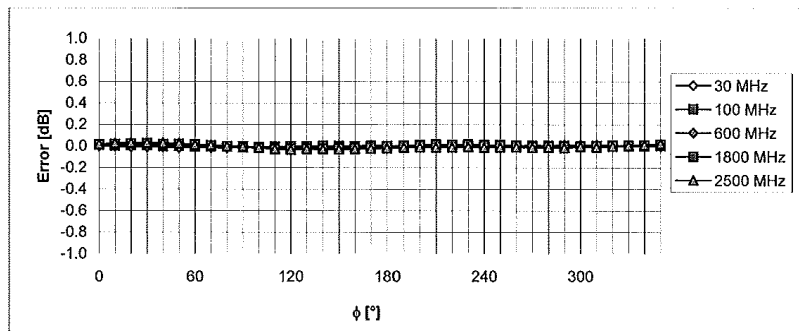
| | | | |
|---|---|--|---|
| <p>FCC ID: A3LSGHT249</p> |  | <p>HAC (RF EMISSIONS) TEST REPORT</p> |  <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 40 of 74</p> |

Receiving Pattern (ϕ), $\vartheta = 0^\circ$





Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

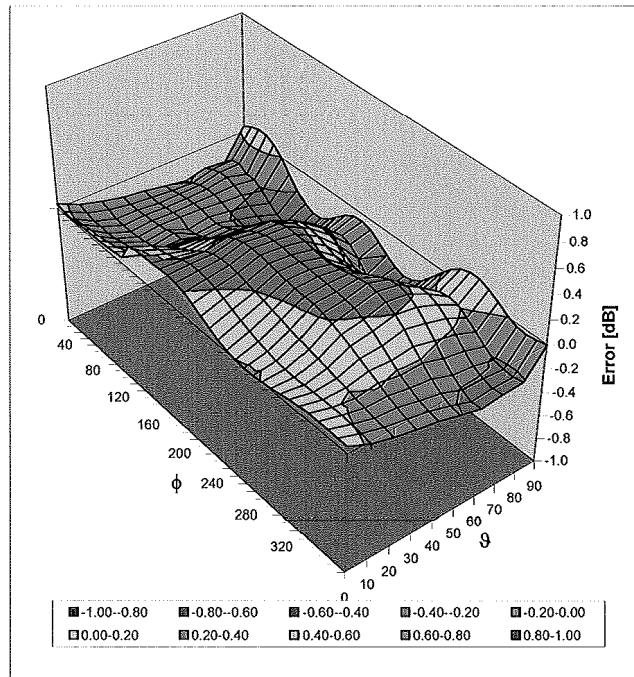
Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

| | | | |
|---|---|---|---|
| <p>FCC ID: A3LSGHT249</p> |  | <p>HAC (RF EMISSIONS) TEST REPORT</p>  | <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 41 of 74</p> |

Deviation from Isotropy in Air
Error (ϕ, θ), f = 900 MHz





Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)

| | | | | |
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Other Probe Parameters

| | |
|---|-------------|
| Sensor Arrangement | Rectangular |
| Connector Angle (°) | 31.1 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 10 mm |
| Tip Diameter | 8.0 mm |
| Probe Tip to Sensor X Calibration Point | 2.5 mm |
| Probe Tip to Sensor Y Calibration Point | 2.5 mm |
| Probe Tip to Sensor Z Calibration Point | 2.5 mm |

| | | | | |
|-----------------------------------|---|--|---|---------------------------------|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 43 of 74 | |

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Accreditation No.: **SCS 108**

Client **PC Test**

Certificate No: **H3-6207_Jan10**

CALIBRATION CERTIFICATE

Object **H3DV6 - SN:6207**

Calibration procedure(s) **QA CAL-03.v5 and QA CAL-25.v2
Calibration procedure for H-field probes optimized for close near field
evaluations in air**

Calibration date: **January 8, 2010**

✓ 010
11/11/10

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|--------------------------------|-----------------------|
| Power meter E4419B | GB41293874 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41495277 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41498087 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 31-Mar-09 (No. 217-01026) | Mar-10 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-09 (No. 217-01028) | Mar-10 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 31-Mar-09 (No. 217-01027) | Mar-10 |
| Reference Probe H3DV6 | SN: 6182 | 3-Oct-09 (No. H3-6182_Oct09) | Oct-10 |
| DAE4 | SN: 789 | 23-Dec-09 (No. DAE4-789_Dec09) | Dec-10 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---------------------------|--------------|-----------------------------------|------------------------|
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-09) | In house check: Oct-11 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-09) | In house check: Oct10 |

| | Name | Function | Signature |
|----------------|---------------|-------------------|-----------|
| Calibrated by: | Katja Pokovic | Technical Manager | |
| Approved by: | Niels Kuster | Quality Manager | |

Issued: January 8, 2010

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Certificate No: H3-6207_Jan10

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| | | | | |
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 44 of 74 |

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

NORM_{x,y,z}: sensitivity in free space
DCP: diode compression point
CF: crest factor (1/duty_cycle) of the RF signal
A, B, C: modulation dependent linearization parameters
Polarization φ : φ rotation around probe axis
Polarization ϑ : ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center),
i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle: information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- **NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- **X, Y, Z(f)_a0a1a2**= X, Y, Z_a0a1a2* *frequency_response* (see Frequency Response Chart).
- **DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- **A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}; A, B, C** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. **VR** is the maximum calibration range expressed in RMS voltage across the diode.
- **Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- **Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- **Connector Angle**: The angle is assessed using the information gained by determining the X_a0a1a2 (no uncertainty required).

| | | | | |
|--|---|---|---------------|--|
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Probe H3DV6

SN:6207

Manufactured: June 12, 2006
Last calibrated: July 17, 2008
Recalibrated: January 8, 2010

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

| | | | | |
|--|---|---|---|--|
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DASY - Parameters of Probe: H3DV6 SN:6207

Basic Calibration Parameters

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|---------------------------------|----------|----------|----------|-----------|
| Norm (A/m / $\sqrt{\mu V}$) a0 | 2.39E-3 | 2.36E-3 | 2.95E-3 | ± 5.1% |
| Norm (A/m / $\sqrt{\mu V}$) a1 | 1.88E-4 | 6.01E-4 | 1.55E-5 | ± 5.1% |
| Norm (A/m / $\sqrt{\mu V}$) a2 | 1.33E-4 | 2.11E-4 | 1.94E-4 | ± 5.1% |
| DCP (mV) ^A | 83.5 | 87.1 | 83.7 | |



Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dBuV | C | VR mV | Unc ^E (k=2) |
|-------|---------------------------|------|---|---------|-----------|------|----------|---------------------------|
| 10000 | CW | 0.00 | X | 0.00 | 0.00 | 1.00 | 300 | ± 1.5 % |
| | | | Y | 0.00 | 0.00 | 1.00 | 300 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 300 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

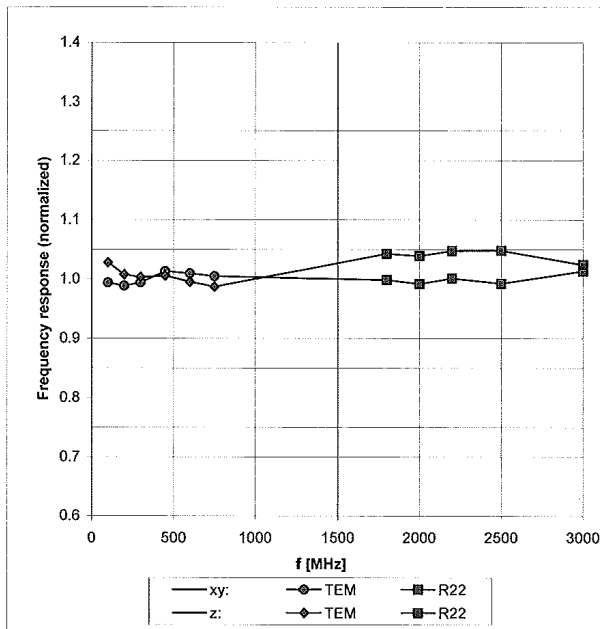
^A numerical linearization parameter: uncertainty not required

^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



| | | | | |
|-----------------------------------|---|--|---|---------------------------------|
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Frequency Response of H-Field

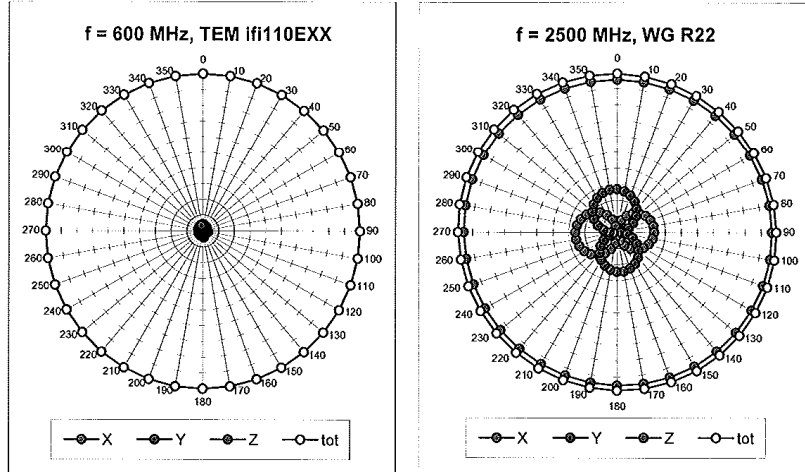
(TEM-Cell:ifi110 EXX, Waveguide R22)



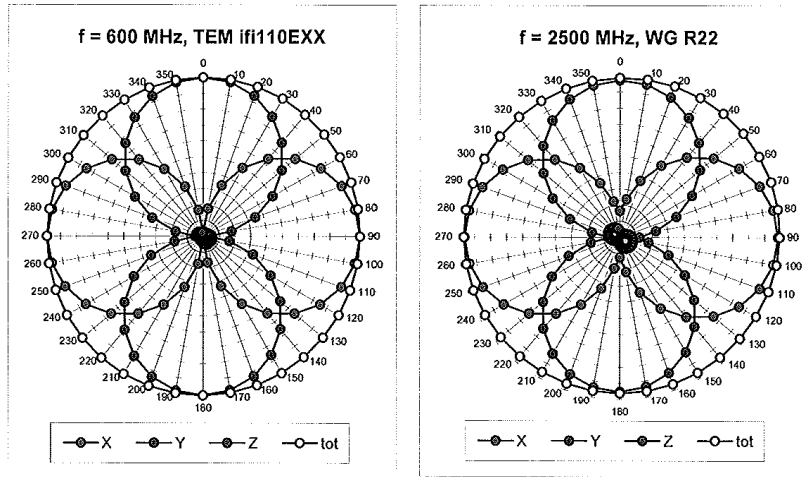
Uncertainty of Frequency Response of H-field: ± 6.3% (k=2)



| | | | |
|---|---|--|---|
| <p>FCC ID: A3LSGHT249</p> |  | <p>HAC (RF EMISSIONS) TEST REPORT</p> |  <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 48 of 74</p> |

Receiving Pattern (ϕ), $\vartheta = 90^\circ$

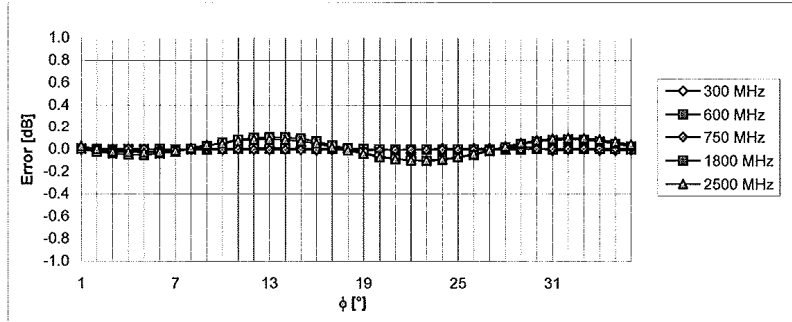


Receiving Pattern (ϕ), $\vartheta = 0^\circ$



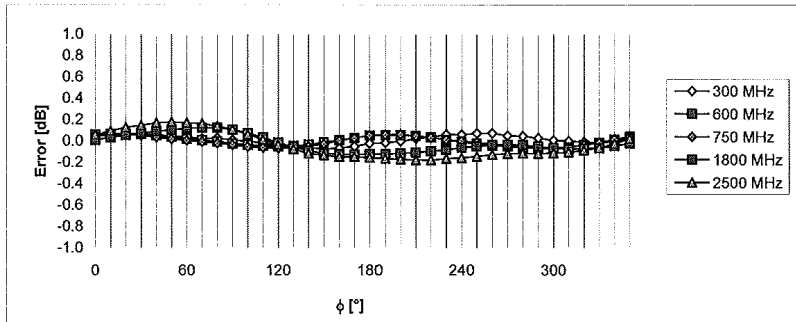
| | | | |
|---|---|--|---|
| <p>FCC ID: A3LSGHT249</p> |  | <p>HAC (RF EMISSIONS) TEST REPORT</p> |  <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 49 of 74</p> |

Receiving Pattern (ϕ), $\vartheta = 90^\circ$





Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

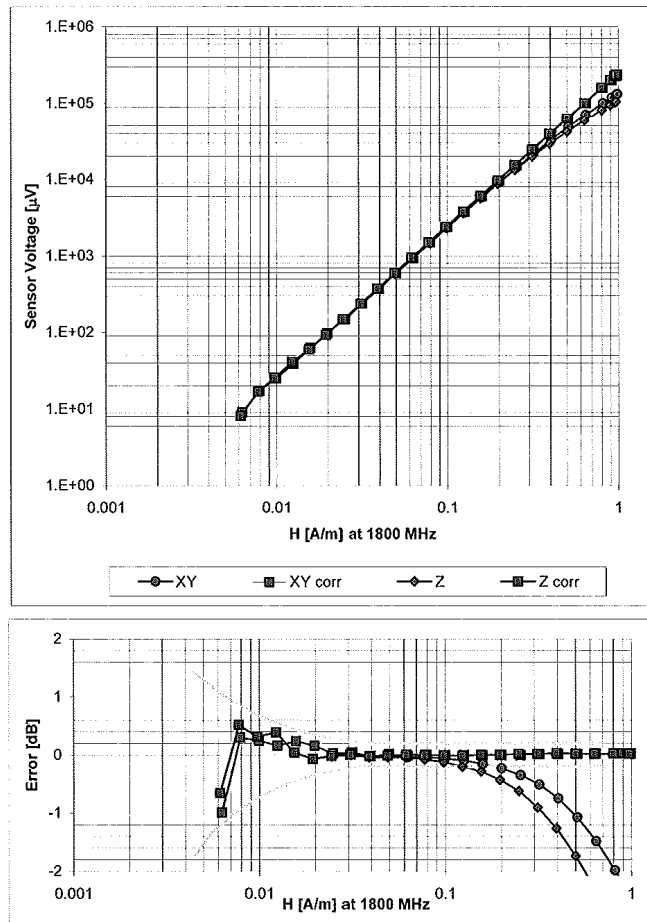
Receiving Pattern (ϕ), $\vartheta = 0^\circ$





Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

| | | | |
|---|---|---|---|
| <p>FCC ID: A3LSGHT249</p> |  | <p>HAC (RF EMISSIONS) TEST REPORT</p>  | <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 50 of 74</p> |

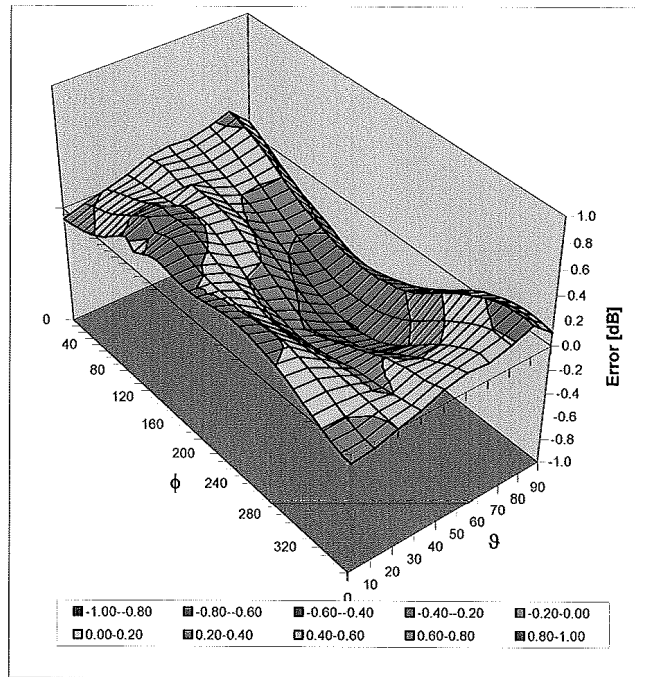
Dynamic Range f(H-field) (Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

| | | | |
|---|---|--|---|
| <p>FCC ID: A3LSGHT249</p> |  | <p>HAC (RF EMISSIONS) TEST REPORT</p> |  <p>Reviewed by: Quality Manager</p> |
| <p>HAC Filename: 0Y1007131167.A3L</p> | <p>Test Dates: July 14-15, 2010</p> | <p>EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth</p> | <p>Page 51 of 74</p> |

Deviation from Isotropy in Air
Error (ϕ, θ), $f = 900$ MHz





Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)

| | | | | |
|--|---|---|---|--|
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Other Probe Parameters

| | |
|---|-------------|
| Sensor Arrangement | Rectangular |
| Connector Angle (°) | -177.4 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 20 mm |
| Tip Diameter | 6.0 mm |
| Probe Tip to Sensor X Calibration Point | 3 mm |
| Probe Tip to Sensor Y Calibration Point | 3 mm |
| Probe Tip to Sensor Z Calibration Point | 3 mm |

| | | | | |
|--|---|---|---|--|
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Accreditation No.: **SCS 108**

Client **PC Test**

Certificate No: **CD835V3-1003_Jan09**

CALIBRATION CERTIFICATE

Object **CD835V3 - SN: 1003**

Calibration procedure(s) **QA CAL-20.v4
Calibration procedure for dipoles in air**

Calibration date: **January 14, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|---------------------------|-------------|-----------------------------------|------------------------|
| Power meter EPM-442A | GB37480704 | 08-Oct-08 (No. 217-00898) | Oct-09 |
| Power sensor HP 8481A | U.S37292783 | 08-Oct-08 (No. 217-00898) | Oct-09 |
| Probe ER3DV6 | SN: 2336 | 22-Dec-08 (No. ER3-2336_Dec08) | Dec-09 |
| Probe H3DV6 | SN: 6065 | 22-Dec-08 (No. H3-6065_Dec08) | Dec-09 |
| DAE4 | SN: 781 | 03-Oct-08 (No. DAE4-781_Oct08) | Oct-09 |
| Secondary Standards | ID # | Check Date (n house) | Scheduled Check |
| Power meter EPM-4419B | GB42420191 | 11-May-05 (in house check Oct-07) | in house check: Oct-09 |
| Power sensor HP 8482A | US37295597 | 11-May-05 (in house check Oct-07) | in house check: Oct-09 |
| Power sensor HP 8482H | 3318A09450 | 08-Jan-02 (in house check Oct-07) | in house check: Oct-09 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-08) | in house check: Oct-09 |
| RF generator E4433B | MY 41310391 | 03-Nov-04 (in house check Oct-07) | in house check: Oct-09 |

Calibrated by: **Name** Claudio Leubler **Function** Laboratory Technician

Signature

Approved by: **Name** Fin Bomholt **Function** Technical Director

Issued: January 15, 2009

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Certificate No: CD835V3-1003_Jan09

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| | | | | |
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Accreditation No.: SCS 108

References

- [1] ANSI-C63.19-2006
American National Standard for Methods of Measurement of Compatibility between Wireless
Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic FR3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 3) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

| | | | | |
|-----------------------------------|--|--|--|---------------------------------|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 55 of 74 |

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

| | | |
|------------------------------------|------------------|----------------------|
| DASY Version | DASY4 | V4.7 B71 |
| DASY PP Version | SEMCAD | V1.8 D184 |
| Phantom | HAC Test Arch | SD HAC P01 BA, #1070 |
| Distance Dipole Top - Probe Center | 10 mm | |
| Scan resolution | dx, dy = 5 mm | area = 20 x 180 mm |
| Frequency | 835 MHz ± 1 MHz | |
| Forward power at dipole connector | 20.0 dBm = 100mW | |
| Input power drift | < 0.05 dB | |

2 Maximum Field values

| H-field 10 mm above dipole surface | condition | interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured | 100 mW forward power | 0.440 A/m |

Uncertainty for H-field measurement: 8.2% (k=2)

| E-field 10 mm above dipole surface | condition | Interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured above high end- | 100 mW forward power | 164.5 V/m |
| Maximum measured above low end | 100 mW forward power | 161.9 V/m |
| Averaged maximum above arm | 100 mW forward power | 163.2 V/m |

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

| Frequency | Return Loss | Impedance |
|-----------|-------------|--------------------|
| 800 MHz | 17.2 dB | (43.3 - j11.0) Ohm |
| 835 MHz | 26.4 dB | (51.5 + j4.7) Ohm |
| 900 MHz | 15.2 dB | (58.7 - j17.1) Ohm |
| 950 MHz | 24.9 dB | (48.0 - j5.3) Ohm |
| 960 MHz | 17.8 dB | (55.5 - j12.6) Ohm |



3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

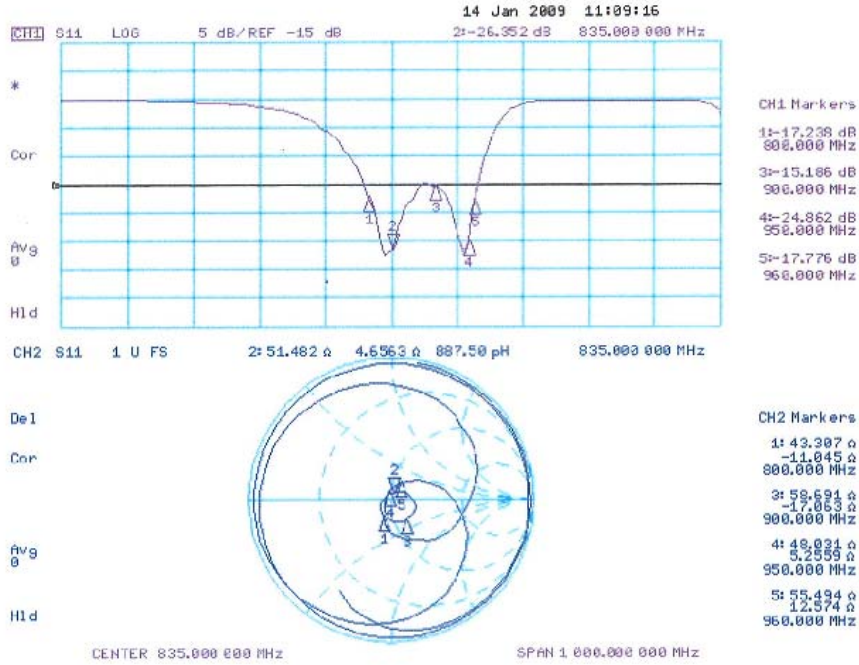
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

| | | | | |
|-----------------------------------|--|--|---|---------------------------------|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 56 of 74 |

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



| | | | | |
|-----------------------------------|--|--|---------|---------------------------------|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 57 of 74 |

3.3.2 DASY4 H-field Result

Date/Time: 13.01.2009 12:02:15

Test Laboratory: SPEAG Lab 2

H_CD835_1003_090113

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1003

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN5065; ; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.440 A/m

Probe Modulation Factor = 1.00

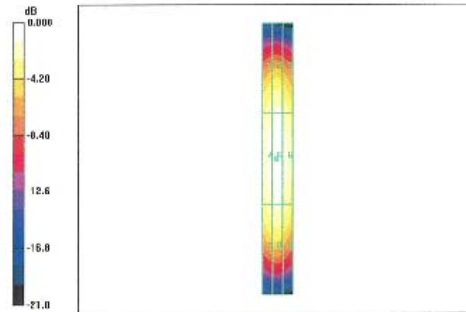
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.467 A/m; Power Drift = -0.015 dB



Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.377 M4 | Grid 2 0.394 M4 | Grid 3 0.367 M4 |
| Grid 4 0.422 M4 | Grid 5 0.440 M4 | Grid 6 0.410 M4 |
| Grid 7 0.374 M4 | Grid 8 0.391 M4 | Grid 9 0.364 M4 |



0 dB = 0.440A/m

| | | | | |
|-----------------------------------|---|--|---|---------------------------------|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 58 of 74 |

3.3.3 DASYS E-field Result

Date/Time: 14.01.2009 16:47:01

Test Laboratory: SPEAG Lab 2

E_CD835_1003_090114

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1003

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASYS4 (High Precision Assessment)

DASYS4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASYS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing

Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 164.5 V/m

Probe Modulation Factor = 1.00

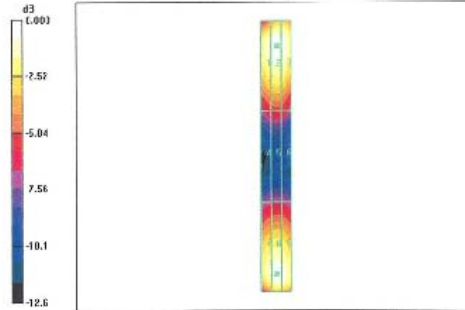
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 105.1 V/m; Power Drift = -0.006 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 157.6 M4 | Grid 2 164.5 M4 | Grid 3 161.9 M4 |
| Grid 4 84.8 M4 | Grid 5 87.7 M4 | Grid 6 85.5 M4 |
| Grid 7 154.4 M4 | Grid 8 161.9 M4 | Grid 9 158.9 M4 |



0 dB = 164.5V/m

| | | | | |
|-----------------------------------|--|--|---------------|---------------------------------|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 59 of 74 | |



Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **PC Test**

Certificate No: **CD1880V3-1002_Jan09**

CALIBRATION CERTIFICATE

Object **CD1880V3 - SN: 1002**

Calibration procedure(s) **QA CAL-20.v4
Calibration procedure for dipoles in air**

Calibration date: **January 21, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|-----------------------|------------|--------------------------------|-----------------------|
| Power meter EPM-442A | GB37480704 | 08-Oct-08 (No. 217-00898) | Oct-09 |
| Power sensor HP 8481A | US37292783 | 08-Oct-08 (No. 217-00898) | Oct-09 |
| Probe ER3DV6 | SN: 2336 | 22-Dec-08 (No. ER3-2336_Dec08) | Dec-09 |
| Probe H3DV6 | SN: 6065 | 22-Dec-08 (No. H3-6065_-Dec08) | Dec-09 |
| DAE4 | SN 781 | 03-Oct-08 (No. DAE4-781_Oct08) | Oct-09 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---------------------------|-------------|-----------------------------------|------------------------|
| Power meter EPM-4419B | GB42420191 | 11-May-05 (in house check Oct-07) | In house check: Oct-09 |
| Power sensor HP 8482A | US37295597 | 11-May-05 (in house check Oct-07) | In house check: Oct-09 |
| Power sensor HP 8482H | 3318A09450 | 08-Jan-02 (in house check Oct-07) | In house check: Oct-09 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-08) | In house check: Oct-09 |
| RF generator E4433B | MY 41310391 | 22-Nov-04 (in house check Oct-07) | In house check: Oct-09 |

| | | | |
|----------------|-----------------|-----------------------|-----------|
| | Name | Function | Signature |
| Calibrated by: | Claudio Leubler | Laboratory Technician | |
| Approved by: | Fin Bomholt | Technical Director | |

Issued: January 21, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

| | | | | |
|--|---|---|--|--|
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| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 60 of 74 |

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
S Service suisse d'étalonnage
C Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

References

- [1] ANSI-C63.19-2006
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- *H-field distribution:* H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

| | | | | |
|--|---|---|---------------|--|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 61 of 74 | |

1. Measurement Conditions

DASY system configuration, as far as not given on page 1.

| | | |
|------------------------------------|------------------|----------------------|
| DASY Version | DASY4 | V4.7 B71 |
| DASY PP Version | SEMCAD | V1.8 B184 |
| Phantom | HAC Test Arch | SD HAC P01 BA, #1070 |
| Distance Dipole Top - Probe Center | 10 mm | |
| Scan resolution | dx, dy = 5 mm | area = 20 x 90 mm |
| Frequency | 1880 MHz ± 1 MHz | |
| Forward power at dipole connector | 20.0 dBm = 100mW | |
| Input power drift | < 0.05 dB | |

2. Maximum Field values

| H-field 10 mm above dipole surface | condition | Interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured | 100 mW forward power | 0.460 A/m |

Uncertainty for H-field measurement: 8.2% (k=2)

| E-field 10 mm above dipole surface | condition | Interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured above high end | 100 mW forward power | 137.6 V/m |
| Maximum measured above low end | 100 mW forward power | 136.8 V/m |
| Averaged maximum above arm | 100 mW forward power | 137.2 V/m |

Uncertainty for E-field measurement: 12.8% (k=2)

3. Appendix

3.1 Antenna Parameters

| Frequency | Return Loss | Impedance |
|-----------------|----------------|-----------------------------|
| 1710 MHz | 28.7 dB | (49.6 + j3.6) Ohm |
| 1880 MHz | 17.2 dB | (47.0 + j13.2) Ohm |
| 1900 MHz | 17.6 dB | (50.6 + j13.3) Ohm |
| 1950 MHz | 21.6 dB | (55.7 + j6.7) Ohm |
| 2000 MHz | 23.2 dB | (46.8 + j5.9) Ohm |



3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

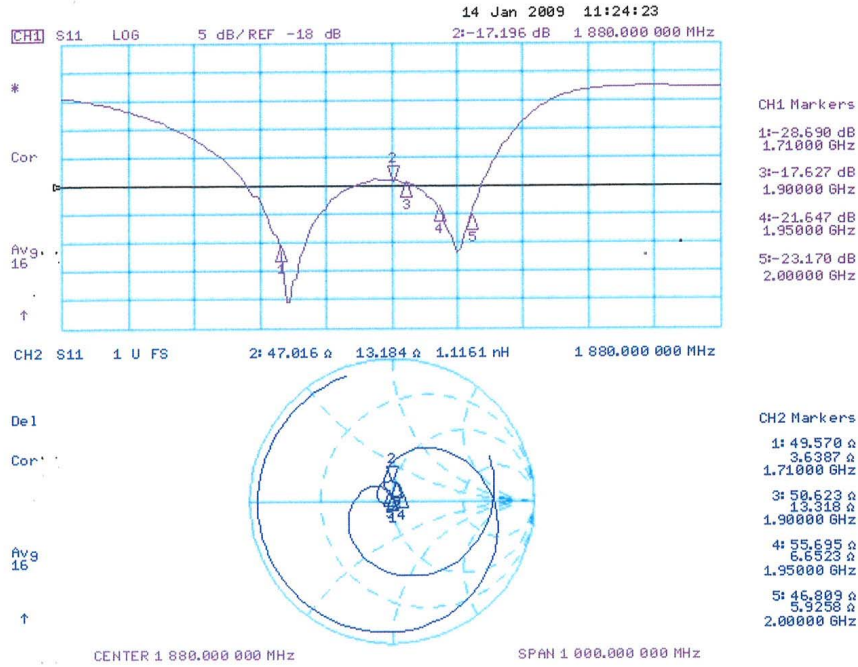
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

| | | | | |
|-----------------------------------|---|--|---|---------------------------------|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 62 of 74 |

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



| | | | | |
|-----------------------------------|--|--|---------|---------------------------------|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | | Page 63 of 74 |

3.3.2 DASY4 H-Field Result

Date/Time: 13.01.2009 15:43:46

Test Laboratory: SPEAG Lab 2

**DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002
H_CD1880_1002_090113**

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility

Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.460 A/m

Probe Modulation Factor = 1.00

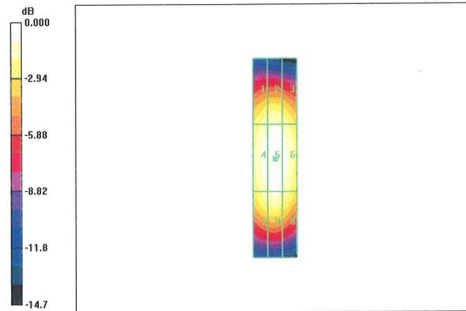
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.487 A/m; Power Drift = -0.013 dB



Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.400 M2 | Grid 2 0.418 M2 | Grid 3 0.397 M2 |
| Grid 4 0.441 M2 | Grid 5 0.460 M2 | Grid 6 0.436 M2 |
| Grid 7 0.406 M2 | Grid 8 0.426 M2 | Grid 9 0.401 M2 |



0 dB = 0.460A/m

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 64 of 74 | |

3.3.3 DASY4 E-Field Result

Date/Time: 14.01.2009 14:17:10

Test Laboratory: SPEAG Lab 2

E_CD1880_1002_090114

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility

Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 137.6 V/m

Probe Modulation Factor = 1.00

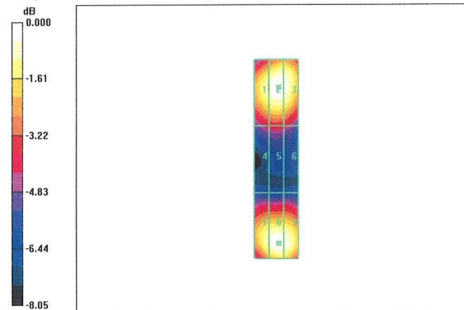
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 154.8 V/m; Power Drift = -0.008 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 129.9 M2 | Grid 2 136.8 M2 | Grid 3 135.0 M2 |
| Grid 4 87.0 M3 | Grid 5 90.1 M3 | Grid 6 87.0 M3 |
| Grid 7 129.6 M2 | Grid 8 137.6 M2 | Grid 9 136.1 M2 |



0 dB = 137.6V/m

| | | | | |
|-----------------------------------|--|--|---------------|---------------------------------|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 65 of 74 | |

4 Additional Measurements

4.1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

| | | |
|---|-------------------------|----------------------|
| DASY Version | DASY4 | V4.7 B71 |
| DASY PP Version | SEMCAD | V1.8 B184 |
| Phantom | HAC Test Arch | SD HAC P01 BA, #1070 |
| Distance Dipole Top - Probe Center | 10 mm | |
| Scan resolution | dx, dy = 5 mm | area = 20 x 90 mm |
| Frequency | 1730 MHz ± 1 MHz | |
| Forward power at dipole connector | 20.0 dBm = 100mW | |
| Input power drift | < 0.05 dB | |



4.2 Maximum Field values

| H-field 10 mm above dipole surface | condition | Interpolated maximum |
|---|----------------------|-----------------------------|
| Maximum measured | 100 mW forward power | 0.478 A/m |

Uncertainty for H-field measurement: 8.2% (k=2)

| E-field 10 mm above dipole surface | condition | Interpolated maximum |
|---|----------------------|-----------------------------|
| Maximum measured above high end | 100 mW forward power | 148.3 V/m |
| Maximum measured above low end | 100 mW forward power | 143.2 V/m |
| Averaged maximum above arm | 100 mW forward power | 145.8 V/m |

Uncertainty for E-field measurement: 12.8% (k=2)

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 66 of 74 | |

4.3.1 DASY4 H-Field Result

Date/Time: 21.01.2009 15:34:35

Test Laboratory: SPEAG Lab 2

H_CD1880_1002_090121

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002

Communication System: CW; Frequency: 1730 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm @ 1730 MHz/Hearing Aid

Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.478 A/m

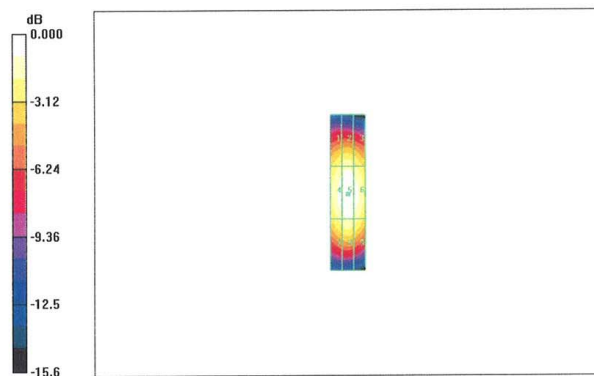
Probe Modulation Factor = 1.00

Reference Value = 0.508 A/m; Power Drift = -0.003 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.396 M2 | Grid 2 0.412 M2 | Grid 3 0.391 M2 |
| Grid 4 0.457 M2 | Grid 5 0.478 M2 | Grid 6 0.453 M2 |
| Grid 7 0.408 M2 | Grid 8 0.429 M2 | Grid 9 0.405 M2 |



0 dB = 0.478A/m

| | | | | |
|-----------------------------------|--|--|---------------|---------------------------------|
| FCC ID: A3LSGHT249 | PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 67 of 74 | |

4.3.2 DASY4 E-Field Result

Date/Time: 21.01.2009 16:17:59

Test Laboratory: SPEAG Lab 2

E_CD1880_1002_090121

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002

Communication System: CW; Frequency: 1730 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm @ 1730 MHz/Hearing Aid

Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 148.3 V/m

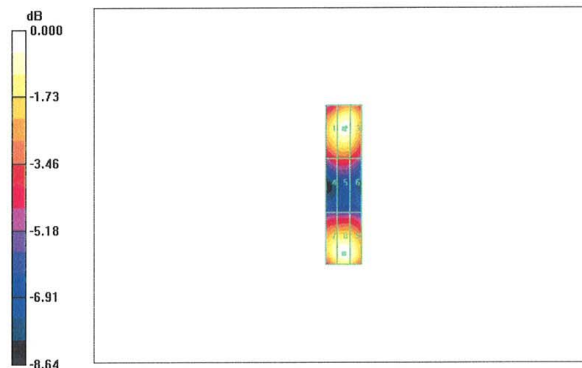
Probe Modulation Factor = 1.00

Reference Value = 168.2 V/m; Power Drift = 0.001 dB



Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 137.9 M2 | Grid 2 143.2 M2 | Grid 3 139.5 M2 |
| Grid 4 98.3 M3 | Grid 5 101.0 M3 | Grid 6 96.9 M3 |
| Grid 7 142.4 M2 | Grid 8 148.3 M2 | Grid 9 143.3 M2 |





0 dB = 148.3V/m

| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 68 of 74 | |

14. CONCLUSION



The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.



| | | | | |
|--|---|---|---|--|
| FCC ID: A3LSGHT249 |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Reviewed by: Quality Manager |
| HAC Filename: 0Y1007131167.A3L | Test Dates: July 14-15, 2010 | EUT Type: 850/1900 GSM/GPRS/EDGE Phone with Bluetooth | Page 69 of 74 | |

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